



150V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)} Max	I _D Max T _A = +25°C
150V	$67m\Omega$ @ $V_{GS} = 10V$	4.5A

Description and Applications

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}), yet maintain superior switching performance, making it ideal for high efficiency power management applications.

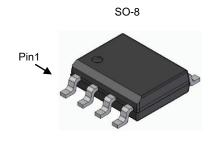
- High Frequency Switching
- Synchronous Rectification
- DC-DC Converters

Features and Benefits

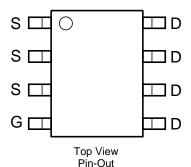
- High Conversion Efficiency
- Low R_{DS(ON)} Minimizes On-State Losses
- Low Input Capacitance
- Fast Switching Speed
- 100% Unclamped Inductive Switching (UIS) Test in Production -Ensures More Reliable and Robust End Application
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

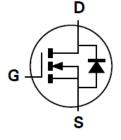
Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 3 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.074 grams (Approximate)



Top View





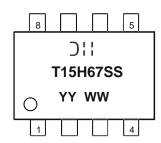
Equivalent Circuit

Ordering Information (Note 4)

Part Number		Case	Packaging	
DMT15H067SSS-13		SO-8	2,500/Tape & Reel	
Notes:	Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.			

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- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

Marking Information



);; = Manufacturer's Marking T15H67SS = Product Type Marking Code YYWW = Date Code Marking YY or \overline{YY} = Year (ex: 19 = 2019) WW = Week (01 to 53)



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage		V_{DSS}	150	V
Gate-Source Voltage		V_{GSS}	±20	V
Continuous Dunin Comment (Alata C) V 40V	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	4.5 3.6	А
Continuous Drain Current (Note 6) V _{GS} = 10V	$T_C = +25$ °C $T_C = +70$ °C	I _D	13 10	А
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	I _{DM}	28	Α	
Maximum Continuous Body Diode Forward Current (Note 6)	Is	13	Α	
Pulsed Body Diode Forward Current (10µs Pulse, Duty Cycle =	I _{SM}	28	Α	
Avalanche Current, L = 1mH		I _{AS}	11.7	Α
Avalanche Energy, L = 1mH		E _{AS}	68.4	mJ

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	P _D	1.3	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ hetaJA}$	94	°C/W
Total Power Dissipation (Note 6)	P _D	2	W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	59	°C/W
Thermal Resistance, Junction to Case (Note 6)	R _θ JC	7	°C/W
Operating and Storage Temperature Range	T _{J,} T _{STG}	-55 to +150	°C

Electrical Characteristics (T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	150	_	1	V	$V_{GS} = 0V, I_{D} = 10mA$	
Zero Gate Voltage Drain Current	I _{DSS}			1	μΑ	$V_{DS} = 120V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	$V_{GS(TH)}$	2	_	4	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
Static Drain-Source On-Resistance	R _{DS(ON)}		53	67	mΩ	$V_{GS} = 10V, I_D = 4.1A$	
Diode Forward Voltage	V_{SD}	_	0.8	1	V	$V_{GS} = 0V, I_S = 4.1A$	
DYNAMIC CHARACTERISTICS (Note 8)						•	
Input Capacitance	C _{iss}	1	425	_		V _{DS} = 75V, V _{GS} = 0V f = 1MHz	
Output Capacitance	Coss		82	-	pF		
Reverse Transfer Capacitance	Crss	_	2.8	_			
Gate Resistance	Rg	_	1.4	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge	Qg	_	6.4	_		V _{DS} = 75V, I _D = 4.1A, V _{GS} = 10V	
Gate-Source Charge	Q _{gs}	_	3	_	nC		
Gate-Drain Charge	Q_{gd}	_	1.6	_			
Turn-On Delay Time	t _{D(ON)}		6.4	_		$V_{DS} = 75V, V_{GS} = 10V,$ $I_{D} = 4.1A, R_{g} = 6\Omega$	
Turn-On Rise Time	t _R	_	2.9	_	20		
Turn-Off Delay Time	t _{D(OFF)}		8.4	_	ns		
Turn-Off Fall Time	t _F	_	5.4	_			
Reverse Recovery Time	t _{RR}		47	_	ns	1 44A di/dt 400A/:	
Reverse Recovery Charge	Q_{RR}	I	91		nC	$I_F = 4.1A$, di/dt = 100A/ μ s	

5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

Solution in the district of States (2004). 202 copper, with 1 finch square copper plate.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.





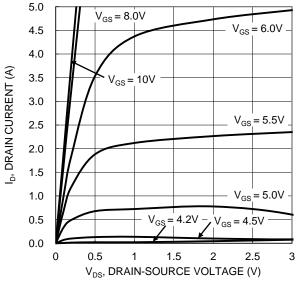
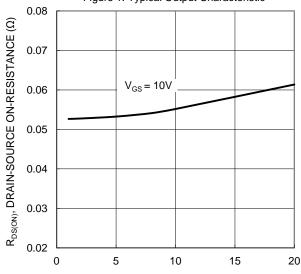


Figure 1. Typical Output Characteristic



I_D, DRAIN-SOURCE CURRENT (A) Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

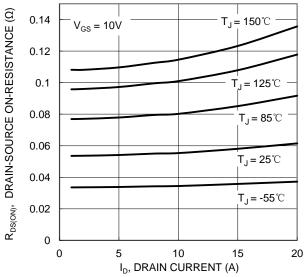


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature

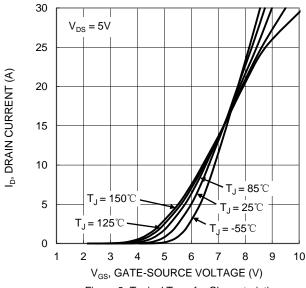


Figure 2. Typical Transfer Characteristic

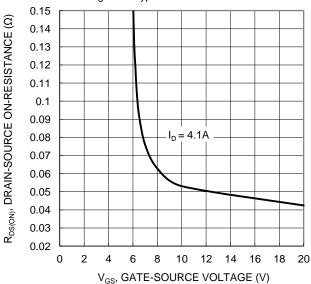


Figure 4. Typical Transfer Characteristic

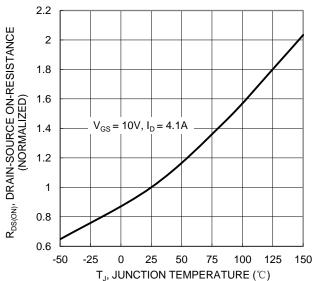
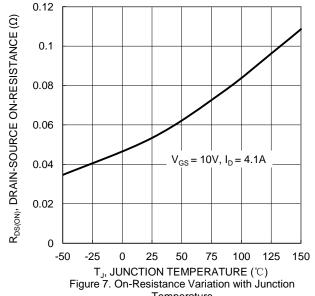
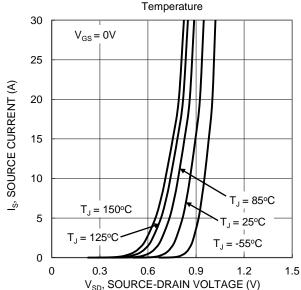


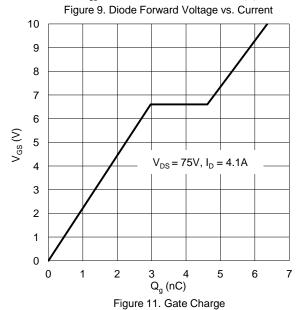
Figure 6. On-Resistance Variation with Junction Temperature

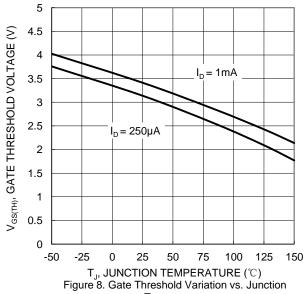


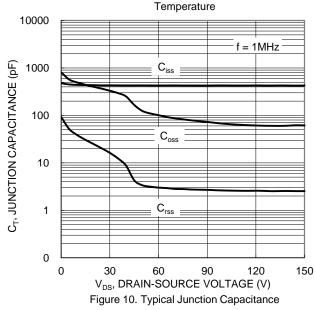


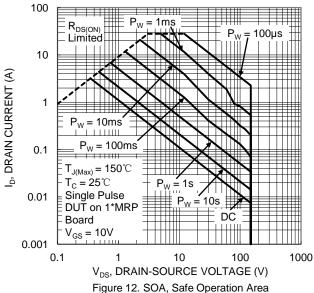














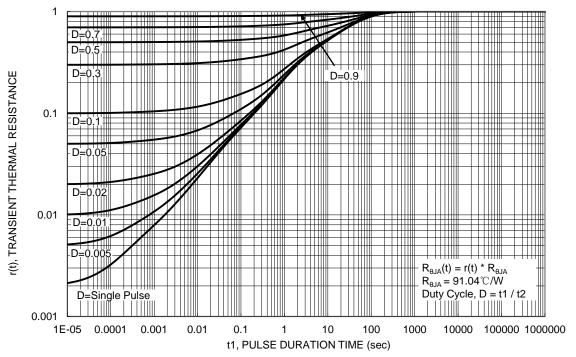


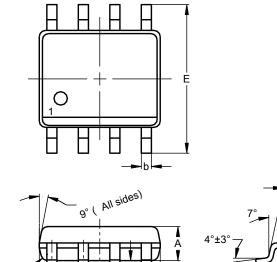
Figure 13. Transient Thermal Resistance

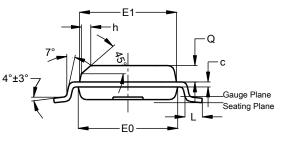


Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

SO-8



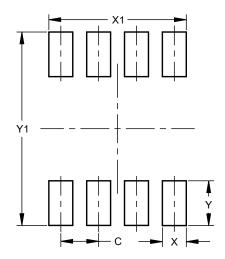


SO-8				
Dim	Min	Max	Тур	
Α	1.40	1.50	1.45	
A1	0.10	0.20	0.15	
b	0.30	0.50	0.40	
С	0.15	0.25	0.20	
D	4.85	4.95	4.90	
Е	5.90	6.10	6.00	
E1	3.80	3.90	3.85	
E0	3.85	3.95	3.90	
е			1.27	
h	1		0.35	
L	0.62	0.82	0.72	
Q	0.60	0.70	0.65	
All Dimensions in mm				

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

SO-8



Dimensions	Value (in mm)		
С	1.27		
Х	0.802		
X1	4.612		
Υ	1.505		
Y1	6.50		



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